

Notice of References Cited

Application/Control No.

10/826,207

Applicant(s)/Patent Under
Reexamination
LEE ET AL.

Examiner

MATTHEW D. MATZEK

Art Unit

1794

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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	N	WO 00/44975	08-2000	WIPO	LIANG et al.	D06N 5/00
	O					
	P					
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NON-PATENT DOCUMENTS

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